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PLUS Search Results for S/N 10055088, Searched August 09, 2004

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4801870	5247522
5930270	5337414
5982681	5396596
5341096	5406438
5652754	5608275
5325062	5612488
5218196	5796274
5548463	5867491
5559664	5939802
6101458	6204493
5727000	6222514
4527272	6222514
6125465	5422891
6526356	5311137
6701477	6055661
6000042	6175244
6170062	5630048
5511162	5933594
5946214	6076078
6553329	6128755
5214577	4494717
4528458	4617630
4990895	5195046
5003573	5819027
5335230	5862125
5448176	6002260
5574753	6026073
5636137	6122282
5963850	6148157
5963312	6147966
6173440	6169489
6433558	6754845
6636048	5260946
5386796	5796935
5960113	5260947

5269016	5321354
5940367	5446399
4284522	5600576
5333130	5825191
5533005	4472789
5581713	4795982
5694615	5425035
6373838	5548211
6392401	5673028
6446218	6028441
6453468	6058502
4371832	6087846
5867358	6114181
4324542	3882386
4520348	4039813

Most Frequently Occurring Classifications of Patents Returned
From A Search of 10055088 on August 09, 2004

Original Classifications
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4   714/732
4   714/736
3   324/765
2   324/767
2   340/635
2   345/84
2   370/221
2   702/35
2   714/26
2   714/4
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Cross-Reference Classifications
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5   714/732
4   714/736
3   324/765
3   324/770
3   340/653
3   714/47
3   714/733
2   307/44
2   307/80
2   324/117R
2   324/537
2   324/543
2   324/73.1
2   340/516
2   345/55
2   359/326
2   361/154
2   370/225
2   703/2
2   713/340
2   714/2
2   714/40
2   714/734
2   714/737
2   714/738
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Combined Classifications
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9   714/732
8   714/736
6   324/765
4   714/47
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4	714/733
3	324/537
3	324/73.1
3	324/770
3	340/635
3	340/653
3	370/225
3	713/340
3	714/4
3	714/40
3	714/737
2	250/221
2	307/44
2	307/64
2	307/80
2	324/117R
2	324/127
2	324/158.1
2	324/509
2	324/522
2	324/543
2	324/628
2	324/751
2	324/767
2	340/516
2	345/55
2	345/84
2	359/326
2	361/104
2	361/154
2	365/201
2	370/221
2	370/228
2	702/35
2	703/2
2	714/11
2	714/2
2	714/26
2	714/724
2	714/734
2	714/738

10055088_CLSTITLES
Titles of Most Frequently Occurring Classifications of Patents Returned
From A Search of 10055088 on August 09, 2004

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9  714/732        (4 OR, 5 XR)
        Class   714 :  ERROR DETECTION/CORRECTION AND FAULT
                          DETECTION/RECOVERY
        714/699           PULSE OR DATA ERROR HANDLING
        714/724           .Digital logic testing
        714/732           ..Signature analysis


8  714/736        (4 OR, 4 XR)
        Class   714 :  ERROR DETECTION/CORRECTION AND FAULT
                          DETECTION/RECOVERY
        714/699           PULSE OR DATA ERROR HANDLING
        714/724           .Digital logic testing
        714/736           ..Device response compared to expected
                             fault-free response


6  324/765        (3 OR, 3 XR)
        Class   324 :  ELECTRICITY:  MEASURING AND TESTING
        324/500           FAULT DETECTING IN ELECTRIC CIRCUITS AND OF
                             ELECTRIC COMPONENTS
        324/537           .Of individual circuit component or element
        324/765           ..Test of semiconductor device


4  714/47         (1 OR, 3 XR)
        Class   714 :  ERROR DETECTION/CORRECTION AND FAULT
                          DETECTION/RECOVERY
        714/100           DATA PROCESSING SYSTEM ERROR OR FAULT HANDLING

        714/1             .Reliability and availability
        714/47            ..Performance monitoring for fault avoidance


4  714/733        (1 OR, 3 XR)
        Class   714 :  ERROR DETECTION/CORRECTION AND FAULT
                          DETECTION/RECOVERY
        714/699           PULSE OR DATA ERROR HANDLING
        714/724           .Digital logic testing
        714/733           ..Built-in testing circuit (BILBO)


3  324/537        (1 OR, 2 XR)
        Class   324 :  ELECTRICITY:  MEASURING AND TESTING
        324/500           FAULT DETECTING IN ELECTRIC CIRCUITS AND OF
                             ELECTRIC COMPONENTS
        324/537           .Of individual circuit component or element
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3   324/73.1   (1 OR, 2 XR)
        Class   324 :   ELECTRICITY: MEASURING AND TESTING
        324/73.1   PLURAL, AUTOMATICALLY SEQUENTIAL TESTS

3   324/770   (0 OR, 3 XR)
        Class   324 :   ELECTRICITY: MEASURING AND TESTING
        324/500   FAULT DETECTING IN ELECTRIC CIRCUITS AND OF
                                ELECTRIC COMPONENTS
        324/537   .Of individual circuit component or element
        324/770   ..Liquid crystal device test

3   340/635   (2 OR, 1 XR)
        Class   340 :   COMMUNICATIONS: ELECTRICAL
        340/500   CONDITION RESPONSIVE INDICATING SYSTEM
        340/540   .Specific condition
        340/635   ..Condition of electrical apparatus

3   340/653   (0 OR, 3 XR)
        Class   340 :   COMMUNICATIONS: ELECTRICAL
        340/500   CONDITION RESPONSIVE INDICATING SYSTEM
        340/540   .Specific condition
        340/635   ..Condition of electrical apparatus
        340/653   ...Electronic circuit or component

3   370/225   (1 OR, 2 XR)
        Class   370 :   MULTIPLEX COMMUNICATIONS
        370/216   FAULT RECOVERY
        370/225   .Bypass an inoperative channel

3   713/340   (1 OR, 2 XR)
        Class   713 :   ELECTRICAL COMPUTERS AND DIGITAL PROCESSING
                                SYSTEMS: SUPPORT
        713/300   COMPUTER POWER CONTROL
        713/340   .Having power source monitoring

3   714/4   (2 OR, 1 XR)
        Class   714 :   ERROR DETECTION/CORRECTION AND FAULT
                                DETECTION/RECOVERY
        714/100   DATA PROCESSING SYSTEM ERROR OR FAULT HANDLING

        714/1   .Reliability and availability
        714/2   ..Fault recovery
        714/3   ...By masking or reconfiguration
        714/4   ....Of network

3   714/40   (1 OR, 2 XR)
        Class   714 :   ERROR DETECTION/CORRECTION AND FAULT
                                DETECTION/RECOVERY

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        714/100        DATA PROCESSING SYSTEM ERROR OR FAULT HANDLING

        714/1          .Reliability and availability
        714/25         ..Fault locating (i.e., diagnosis or testing)

        714/40         ...Component dependent technique


  3   714/737      (1 OR,  2 XR)
        Class    714 :   ERROR DETECTION/CORRECTION AND FAULT
                              DETECTION/RECOVERY
        714/699        PULSE OR DATA ERROR HANDLING
        714/724        .Digital logic testing
        714/737        ..Device response compared to fault
                              dictionary/truth table


  2   250/221      (1 OR,  1 XR)
        Class    250 :   RADIANT ENERGY
        250/200        PHOTOCELLS; CIRCUITS AND APPARATUS
        250/216        .Optical or pre-photocell system
        250/221        ..Controlled by article, person, or animal


  2   307/44       (0 OR,  2 XR)
        Class    307 :   ELECTRICAL TRANSMISSION OR INTERCONNECTION
                              SYSTEMS
        307/43         PLURAL SUPPLY CIRCUITS OR SOURCES
        307/44         .One source floats across or compensates for
                              other source


  2   307/64       (1 OR,  1 XR)
        Class    307 :   ELECTRICAL TRANSMISSION OR INTERCONNECTION
                              SYSTEMS
        307/43         PLURAL SUPPLY CIRCUITS OR SOURCES
        307/64         .Substitute or emergency source


  2   307/80       (0 OR,  2 XR)
        Class    307 :   ELECTRICAL TRANSMISSION OR INTERCONNECTION
                              SYSTEMS
        307/43         PLURAL SUPPLY CIRCUITS OR SOURCES
        307/80         .Selective or optional sources


  2   324/117R     (0 OR,  2 XR)
        Class    324 :   ELECTRICITY:  MEASURING AND TESTING
        324/76.11      MEASURING, TESTING, OR SENSING ELECTRICITY, PE
R
                              SE
        324/117R       .Magnetic saturation (e.g., in field or in
                              amplifier)
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 2   324/127        (1 OR, 1 XR)
        Class  324 :  ELECTRICITY:  MEASURING AND TESTING
        324/76.11      MEASURING, TESTING, OR SENSING ELECTRICITY, PE
R
                         SE
        324/126        .With coupling means (e.g., attenuator, shunt)

        324/127        ..Transformer (e.g., split core admits
                         conductor carrying unknown current)


 2   324/158.1      (1 OR, 1 XR)
        Class  324 :  ELECTRICITY:  MEASURING AND TESTING
        324/158.1      MISCELLANEOUS


 2   324/509        (1 OR, 1 XR)
        Class  324 :  ELECTRICITY:  MEASURING AND TESTING
        324/500        FAULT DETECTING IN ELECTRIC CIRCUITS AND OF
                         ELECTRIC COMPONENTS
        324/509        .Of ground fault indication


 2   324/522        (1 OR, 1 XR)
        Class  324 :  ELECTRICITY:  MEASURING AND TESTING
        324/500        FAULT DETECTING IN ELECTRIC CIRCUITS AND OF
                         ELECTRIC COMPONENTS
        324/512        .For fault location
        324/522        ..By voltage or current measuring


 2   324/543        (0 OR, 2 XR)
        Class  324 :  ELECTRICITY:  MEASURING AND TESTING
        324/500        FAULT DETECTING IN ELECTRIC CIRCUITS AND OF
                         ELECTRIC COMPONENTS
        324/537        .Of individual circuit component or element
        324/543        ..Single conductor cable


 2   324/628        (1 OR, 1 XR)
        Class  324 :  ELECTRICITY:  MEASURING AND TESTING
        324/600        IMPEDANCE, ADMITTANCE OR OTHER QUANTITIES
                         REPRESENTATIVE OF ELECTRICAL STIMULUS/RE
SPONSE
                         RELATIONSHIPS
        324/612        .Parameter related to the reproduction or
                         fidelity of a signal affected by a circui
t under test
        324/627        ..Shielding effectiveness (SE)
        324/628        ...Circuit interference (e.g., crosstalk)
                         measurement


 2   324/751        (1 OR, 1 XR)
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      Class   324 :  ELECTRICITY:  MEASURING AND TESTING
      324/500         FAULT DETECTING IN ELECTRIC CIRCUITS AND OF
                        ELECTRIC COMPONENTS
      324/537         .Of individual circuit component or element
      324/750         ..System sensing fields adjacent device under
                        test (DUT)
      324/751         ...Using electron beam probe


  2  324/767      (2 OR, 0 XR)
      Class   324 :  ELECTRICITY:  MEASURING AND TESTING
      324/500         FAULT DETECTING IN ELECTRIC CIRCUITS AND OF
                        ELECTRIC COMPONENTS
      324/537         .Of individual circuit component or element
      324/765         ..Test of semiconductor device
      324/766         ...With barrier layer
      324/767         ....Diode


  2  340/516      (0 OR, 2 XR)
      Class   340 :  COMMUNICATIONS:  ELECTRICAL
      340/500         CONDITION RESPONSIVE INDICATING SYSTEM
      340/501         .With particular system function (e.g.,
                        temperature compensation, calibration)
      340/514         ..Testing
      340/516         ...Automatic (e.g., periodic, start-up)


  2  345/55       (0 OR, 2 XR)
      Class   345 :  COMPUTER GRAPHICS PROCESSING, OPERATOR
                        INTERFACE PROCESSING, AND SELECTIVE VISUAL
DISPLAY
                        SYSTEMS
      345/30          PLURAL PHYSICAL DISPLAY ELEMENT CONTROL SYSTEM
                        (E.G., NON-CRT)
      345/55          .Display elements arranged in matrix (e.g.,
                        rows and columns)


  2  345/84       (2 OR, 0 XR)
      Class   345 :  COMPUTER GRAPHICS PROCESSING, OPERATOR
                        INTERFACE PROCESSING, AND SELECTIVE VISUAL
DISPLAY
                        SYSTEMS
      345/30          PLURAL PHYSICAL DISPLAY ELEMENT CONTROL SYSTEM
                        (E.G., NON-CRT)
      345/55          .Display elements arranged in matrix (e.g.,
                        rows and columns)
      345/84          ..Light-controlling display elements


  2  359/326      (0 OR, 2 XR)
      Class   359 :  OPTICS:  SYSTEMS
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        359/326        OPTICAL FREQUENCY CONVERTER

 2  361/104        (1 OR, 1 XR)
        Class   361 :  ELECTRICITY:  ELECTRICAL SYSTEMS AND DEVICES

        361/1          SAFETY AND PROTECTION OF SYSTEMS AND DEVICES
        361/103        .Circuit interruption by thermal sensing
        361/104        ..With fuse

 2  361/154        (0 OR, 2 XR)
        Class   361 :  ELECTRICITY:  ELECTRICAL SYSTEMS AND DEVICES

        361/139        CONTROL CIRCUITS FOR ELECTROMAGNETIC DEVICES
        361/143        .Systems for magnetizing, demagnetizing, or
                           controlling the magnetic field
        361/152        ..Including particular drive circuit
        361/154        ...Including means to establish plural distinc
t
                       current levels (e.g., high, low)

 2  365/201        (1 OR, 1 XR)
        Class   365 :  STATIC INFORMATION STORAGE AND RETRIEVAL
        365/189.01     READ/WRITE CIRCUIT
        365/201        .Testing

 2  370/221        (2 OR, 0 XR)
        Class   370 :  MULTIPLEX COMMUNICATIONS
        370/216        FAULT RECOVERY
        370/221        .Bypass an inoperative station

 2  370/228        (1 OR, 1 XR)
        Class   370 :  MULTIPLEX COMMUNICATIONS
        370/216        FAULT RECOVERY
        370/225        .Bypass an inoperative channel
        370/228        ..Spare channel

 2  702/35         (2 OR, 0 XR)
        Class   702 :  DATA PROCESSING: MEASURING, CALIBRATING, OR
                           TESTING
        702/1          MEASUREMENT SYSTEM IN A SPECIFIC ENVIRONMENT
        702/33         .Mechanical measurement system
        702/35         ..Flaw or defect detection

 2  703/2          (0 OR, 2 XR)
        Class   703 :  DATA PROCESSING:  STRUCTURAL DESIGN,
                           MODELING, SIMULATION, AND EMULATION
        703/2          MODELING BY MATHEMATICAL EXPRESSION
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2  714/11        (1 OR, 1 XR)
        Class    714 :  ERROR DETECTION/CORRECTION AND FAULT
                           DETECTION/RECOVERY
        714/100         DATA PROCESSING SYSTEM ERROR OR FAULT HANDLING

        714/1           .Reliability and availability
        714/2           ..Fault recovery
        714/3           ...By masking or reconfiguration
        714/10          ....Of processor
        714/11          .....Concurrent, redundantly operating
                           processors


2  714/2         (0 OR, 2 XR)
        Class    714 :  ERROR DETECTION/CORRECTION AND FAULT
                           DETECTION/RECOVERY
        714/100         DATA PROCESSING SYSTEM ERROR OR FAULT HANDLING

        714/1           .Reliability and availability
        714/2           ..Fault recovery


2  714/26        (2 OR, 0 XR)
        Class    714 :  ERROR DETECTION/CORRECTION AND FAULT
                           DETECTION/RECOVERY
        714/100         DATA PROCESSING SYSTEM ERROR OR FAULT HANDLING

        714/1           .Reliability and availability
        714/25          ..Fault locating (i.e., diagnosis or testing)

        714/26          ...Artificial intelligence (e.g., diagnostic
                           expert system)


2  714/724       (1 OR, 1 XR)
        Class    714 :  ERROR DETECTION/CORRECTION AND FAULT
                           DETECTION/RECOVERY
        714/699         PULSE OR DATA ERROR HANDLING
        714/724         .Digital logic testing


2  714/734       (0 OR, 2 XR)
        Class    714 :  ERROR DETECTION/CORRECTION AND FAULT
                           DETECTION/RECOVERY
        714/699         PULSE OR DATA ERROR HANDLING
        714/724         .Digital logic testing
        714/734         ..Structural (in-circuit test)


2  714/738       (0 OR, 2 XR)
        Class    714 :  ERROR DETECTION/CORRECTION AND FAULT
                           DETECTION/RECOVERY
        714/699         PULSE OR DATA ERROR HANDLING
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10055088_CLSTITLES